

Notice of References Cited	Application/Control No. 10/577,325	Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner Bryan E. Wilson	Art Unit 2891	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0015698	01-2003	Baldo et al.	257/40
*	C	US-6,420,057	07-2002	Ueda et al.	428/690
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NON-PATENT DOCUMENTS

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